Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/779,779	NIIYA, HIROTAKA	
Examiner	Art Unit	
Wen-Ying P. Chen	2871	

Wen-Ying P. Chen

SEARCHED					
Class	Subclass	Date	Examiner		
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444.44					

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Key word search on EAST	5/9/2005	wpc		
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